

INFORMATION DISCLOSURE STATEMENT PTO-1449	Atty. Docket No. 042099	<i>10/774,375</i> Serial No. New Annl.
	Applicant(s): Kensaku SHINOZAKI	
	Filing Date: February 10, 2004	Group Art Unit:

U.S. PATENT DOCUMENTS

Examiner Initial	Document No.	Name	Date	Class	Subclass	Filing Date (If appropriate)
<i>M</i>	AA	5,834,140	Wolski et al.	11/10/98		
<i>M</i>	AB	5,171,417	DiFranco et al.	12/15/92		
—	AC					
—	AD					

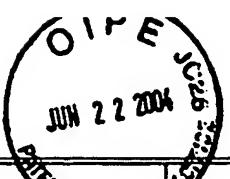
FOREIGN PATENT DOCUMENTS

	Document No.	Date	Country	Translation (Yes or No)
<i>M</i>	AE 40-15327	07/19/65	Japan	No. Cited in the specification.
<i>M</i>	AF 52-17336	02/09/77	Japan	No. Cited in the specification.
<i>M</i>	AG 06-270331	09/27/94	Japan	Abstract. Cited in the specification.
<i>M</i>	AH 11-256389	09/21/99	Japan	Abstract. Cited in the specification.
—	AI			

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<i> </i>	AJ	
<i> </i>	AK	
Examiner	<i>Lahelle</i>	Date Considered <i>7/28/05</i>

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INFORMATION
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CITATION
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Serial No. 10/774,375

Applicant(s): SHINOZAKI, Kensaku

Filing Date: February 10, 2004

Group Art Unit: 1775

U.S. PATENT DOCUMENTS

Examiner Initial		Document No.	Name	Date	Class	Subclass	Filing Date (If appropriate)
ML	AA	2002/0011418 A1	Manabe et al.	01/31/2002	205	191	04/12/2001
ML	AB	5,679,230	Fatcheric et al.	10/21/1997	205	50	08/21/1995
ML	AC	5,863,410	Yates et al.	01/26/1999	205	585	06/23/1997
ML	AD	6,270,645	Yates et al.	08/07/2001	205	77	09/26/1997
ML	AE	3,293,109	Luce et al.	12/20/1966	161	166	09/18/1961

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ML	AG	0 557 073	08/25/1993	Europe	N/A
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ML	AK	European Search Report mailed May 19, 2004 for corresponding foreign application No. 04250762		
	AL			
Examiner		Lahille Date Considered		7/28/05



INFORMATION DISCLOSURE CITATION PTO-1449	Atty. Docket No. 042099	Serial No. 10/774,375
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	AB						
	AC						
	AD						
	AE						

FOREIGN PATENT DOCUMENTS

Examiner Initial		Document No.	Date	Country	Translation (Yes or No)
<u>MR</u>	AF	09-143785	06/03/1997	Japan	Yes (Abstract Only), discussed on page 19 of the present specification as Japanese Patent No. 3,313, 277.
	AG				
	AH				
	AI				
	AJ				

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Examiner	<i>Carillo</i>	Date Considered <i>7/28/05</i>